STL140N4LLF5



N-channel 40 V, 2.2 mΩ typ., 32 A STripFET[™] F5 Power MOSFET in a PowerFLAT[™] 5x6 package

Datasheet - production data



Figure 1: Internal schematic diagram



Features

Order code	VDS	R _{DS(on)} max.	ID
STL140N4LLF5	40 V	2.75 mΩ	32 A

- Low on-resistance R_{DS(on)}
- High avalanche ruggedness
- Low gate drive power loss

Applications

Switching applications

Description

This N-channel Power MOSFET is developed using the STripFET™ F5 technology and has been optimized to achieve very low on-state resistance, contributing to a FoM that is among the best in its class.

Table 1: Device summary

	······································				
Order code	Marking	Package	Packing		
STL140N4LLF5	140N4LF5	PowerFLAT™ 5x6	Tape and reel		

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This is information on a product in full production.

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1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage	40	V
V _{GS}	Gate-source voltage	±22	V
I _D ⁽¹⁾	Drain current (continuous) at Tc = 25 °C	140	А
اD ⁽¹⁾	Drain current (continuous) at T _c = 100 °C	88	А
اD ⁽²⁾	Drain current (continuous) at T _{pcb} = 25 °C	32	А
ID ⁽²⁾	Drain current (continuous) at T _{pcb} = 100 °C	20	А
I _{DM} ⁽³⁾	Drain current (pulsed)	128	А
Ртот ⁽¹⁾	Total dissipation at $T_c = 25 \ ^{\circ}C$	80	W
Ртот ⁽²⁾	Total dissipation at $T_{pcb} = 25 \text{ °C}$	4	W
T _{stg}	Storage temperature range	-55 to 150	°C
Tj	Operating junction temperature range	-55 10 150	U

Notes:

 $^{(1)}\mbox{This}$ value is rated according to $R_{\mbox{thj-case}}.$

 $^{(2)}\mbox{This}$ value is rated according to $R_{\mbox{thj-pcb.}}$

⁽³⁾Pulse width limited by safe operating area.

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R _{thj} -case	Thermal resistance junction-case	1.56	°C/W
Rthj-pcb ⁽¹⁾	Thermal resistance junction-pcb	31.3	°C/W

Notes:

⁽¹⁾When mounted on FR-4 board of 1 inch², 2 oz Cu t <10 sec

Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
lav	Not-repetitive avalanche current, (pulse width limited by T _{jmax})	16	А
Eas	Single pulse avalanche energy (starting $T_J = 25 \text{ °C}$, $I_D = I_{AV}$, $V_{DD} = 24 \text{ V}$)	300	mJ



2 Electrical characteristics

 $T_C = 25$ °C unless otherwise specified

Table 5: On/off-state						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)DSS}$	Drain-source breakdown voltage	$V_{GS}=0~V,~I_D=250~\mu A$	40			V
	I _{DSS} Zero gate voltage drain current	$V_{GS} = 0 V, V_{DS} = 40 V$			1	μΑ
IDSS		$V_{GS} = 0 V, V_{DS} = 40 V,$ T _c = 125 °C ⁽¹⁾			10	μA
Igss	Gate body leakage current	$V_{DS} = 0 V$, $V_{GS} = \pm 22 V$			±100	μA
VGS(th)	Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	1			V
D	Static drain-source	V_{GS} = 10 V, I _D = 16 A		2.2	2.75	mΩ
R _{DS(on)}	on-resistance	$V_{GS} = 4.5 \text{ V}, I_D = 16 \text{ A}$		2.4	3.1	mΩ

Notes:

 $\ensuremath{^{(1)}}\ensuremath{\mathsf{Defined}}$ by design, not subject to production test.

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	5900	-	pF
Coss	Output capacitance	V _{DS} = 25 V, f = 1 MHz,	-	870	-	pF
Crss	Reverse transfer capacitance	V _{GS} = 0 V	-	130	-	рF
Qg	Total gate charge	V _{DD} = 15 V, I _D = 32 A	-	45	-	nC
Q _{gs}	Gate-source charge	V _{GS} = 0 to 4.5 V,	-	14	-	nC
Q _{gd}	Gate-drain charge	see (Figure 14: "Test circuit for gate charge behavior")	-	17	-	nC
R_G	Gate input resistance	f=1 MHz, gate DC bias = 0 V, test signal level = 20 mV, $I_D = 0 A$	-	1.2	-	Ω

Table 6: Dynamic

Table 7: Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time	V_{DD} = 15 V, I_D = 16 A,	-	19	-	ns
tr	Rise time	$R_G = 4.7 \Omega$	-	29	-	ns
t _{d(off)}	Turn-off delay time	V _{GS} = 10 V, (see <i>Figure 13: "Test circuit for</i>	-	90	-	ns
tr	Fall time	resistive load switching times" and Figure 18: "Switching time waveform")	-	21	-	ns



Electrical characteristics

Table 8: Source-drain diode						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Isd	Forward on voltage		-		32	А
I _{SDM} ⁽¹⁾	Source-drain current (pulsed)		-		128	А
Vsd ⁽²⁾	Forward on voltage	I _{SD} = 32 A, V _{GS} =0 V	-		1.1	V
trr	Reverse recovery time I _{SD} = 32 A, di/dt = 100 A/µs,		-	44		ns
Qrr	Reverse recovery charge	V _{DD} = 25 V (see Figure 15: "Test circuit for	-	57		nC
Irrm	Reverse recovery current	inductive load switching and diode recovery times")	-	2.6		А

Notes:

⁽¹⁾Pulse width limited by safe operating area.

 $^{(2)}\mbox{Pulsed:}$ pulse duration=300 $\mbox{\mu s},$ duty cycle 1.5%.











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Electrical characteristics







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3 Test circuits









4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK[®] is an ST trademark.

4.1 PowerFLAT[™] 5x6 type C package information



Figure 19: PowerFLAT™ 5x6 type C package outline



Package information

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Tab	le 9: PowerFLAT™ 5x6 ty	vpe C package mechanica	al data
Dim.		mm	
Dini.	Min.	Тур.	Max.
А	0.80		1.00
A1	0.02		0.05
A2		0.25	
b	0.30		0.50
С	5.80	6.00	6.20
D	5.00	5.20	5.40
D2	4.15		4.45
D3	4.05	4.20	4.35
D4	4.80	5.00	5.20
D5	0.25	0.40	0.55
D6	0.15	0.30	0.45
е		1.27	
E	5.95	6.15	6.35
E2	3.50		3.70
E3	2.35		2.55
E4	0.40		0.60
E5	0.08		0.28
E6	0.20	0.325	0.45
E7	0.75	0.90	1.05
К	1.05		1.35
L	0.725		1.025
L1	0.05	0.15	0.25
θ	0°		12°





4.2 PowerFLAT[™] 5x6 packing information



Figure 22: PowerFLAT™ 5x6 package orientation in carrier tape





Package information

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5 Revision history

Table 10: Document revision history

Date	Revision	Changes
03-Jun-2010	1	First release.
29-Apr-2011	2	Document status promoted from preliminary data to datasheet.
10-Nov-2011	3	Section 4: Package mechanical data has been updated. Minor text changes.
08-Aug-2017	4	Modified <i>Table 1: "Device summary".</i> Updated <i>Section 5: "Package information".</i> Minor text changes.



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